

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination KIM ET AL.	
		Examiner Khai Tran	Art Unit 2611	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0035495 A1	02-2003	Laamanen et al.	375/296
*	B	US-2003/0091111 A1	05-2003	Vaananen, Janne	375/231
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NON-PATENT DOCUMENTS

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